Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/804,080	ARAKAWA ET AL.	
Examiner	Art Unit	
Shun Lee	2878	

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Class	Subclass	Date	Examiner
250	484.4	7/13/2004	SL
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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